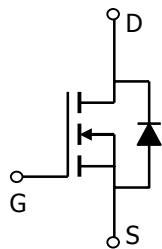
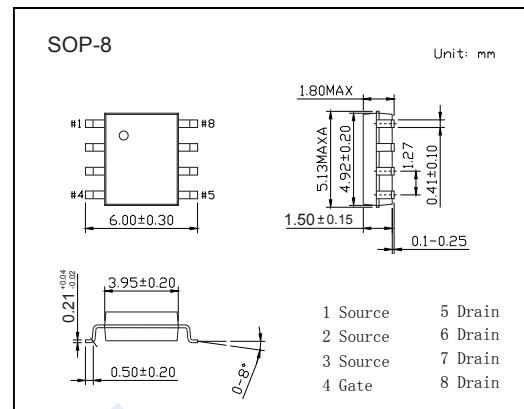


## N-Channel MOSFET

## AO4404 (KO4404)

## ■ Features

- $V_{DS} (V) = 30V$
- $I_D = 8.5 A (V_{GS} = 10V)$
- $R_{DS(ON)} < 24m\Omega (V_{GS} = 10V)$
- $R_{DS(ON)} < 30m\Omega (V_{GS} = 4.5V)$
- $R_{DS(ON)} < 48m\Omega (V_{GS} = 2.5V)$

■ Absolute Maximum Ratings  $T_a = 25^\circ C$ 

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	
Continuous Drain Current	$I_D$	8.5	A
		7.1	
Pulsed Drain Current	$I_{DM}$	60	A
Avalanche Current	$I_{AS}$	15	
Avalanche energy	$E_{AS}$	34	mJ
Power Dissipation	$P_D$	3	W
		2.1	
Thermal Resistance.Junction- to-Ambient	$R_{thJA}$	40	$^\circ C/W$
		75	
Thermal Resistance.Junction- to-Lead	$R_{thJL}$	24	$^\circ C$
Junction Temperature	$T_J$	150	
Storage Temperature Range	$T_{stg}$	-55 to 150	

## N-Channel MOSFET

### AO4404 (KO4404)

■ Electrical Characteristics  $T_a = 25^\circ C$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{DSS}$	$I_D=250 \mu A, V_{GS}=0V$	30			V
Zero Gate Voltage Drain Current	$I_{DS(on)}$	$V_{DS}=30V, V_{GS}=0V$			1	uA
		$V_{DS}=30V, V_{GS}=0V, T_J=55^\circ C$			5	
Gate-Body Leakage Current	$I_{GSS}$	$V_{DS}=0V, V_{GS}=\pm 12V$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.7		1.4	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=8.5A$			24	mΩ
		$V_{GS}=10V, I_D=8.5A, T_J=125^\circ C$			36	
		$V_{GS}=4.5V, I_D=8.5A$			30	
		$V_{GS}=2.5V, I_D=5A$			48	
On State Drain Current	$I_{D(on)}$	$V_{GS}=4.5V, V_{DS}=5V$	40			A
Forward Transconductance	$g_F$	$V_{DS}=5V, I_D=5A$	10			S
Input Capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=15V, f=1MHz$		857	1050	pF
Output Capacitance	$C_{oss}$			97		
Reverse Transfer Capacitance	$C_{rss}$			71	100	
Gate Resistance	$R_g$	$V_{GS}=0V, V_{DS}=0V, f=1MHz$	0.7		2	Ω
Total Gate Charge	$Q_g$	$V_{GS}=4.5V, V_{DS}=15V, I_D=8.5A$		9.7	12	nC
Gate Source Charge	$Q_{gs}$			1.63		
Gate Drain Charge	$Q_{gd}$			3.1		
Turn-On Delay Time	$t_{d(on)}$	$V_{GS}=10V, V_{DS}=15V, R_L=1.8\Omega, R_{GEN}=6\Omega$		3.3	5	ns
Turn-On Rise Time	$t_r$			4.7	7	
Turn-Off Delay Time	$t_{d(off)}$			26	39	
Turn-Off Fall Time	$t_f$			4.1	6.2	
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F= 5A, dI/dt= 100A/us$		15	20	nC
Body Diode Reverse Recovery Charge	$Q_{rr}$			8.6	12	
Maximum Body-Diode Continuous Current	$I_s$				4.3	A
Diode Forward Voltage	$V_{SD}$	$I_s=1A, V_{GS}=0V$			1	V

Note : The static characteristics in Figures 1 to 6 are obtained using  $<300 \mu s$  pulses, duty cycle 0.5% max.

#### ■ Marking

Marking	4404 KC****
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## N-Channel MOSFET

### AO4404 (KO4404)

#### ■ Typical Characteristics

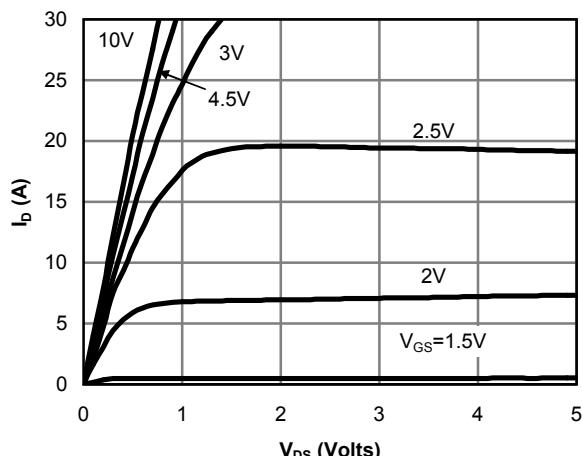


Fig 1: On-Region Characteristics

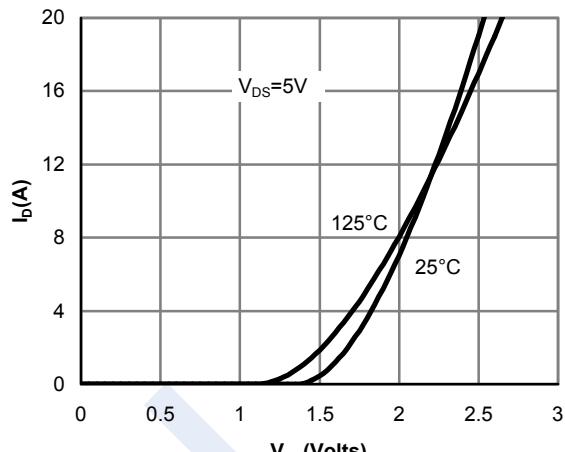


Figure 2: Transfer Characteristics

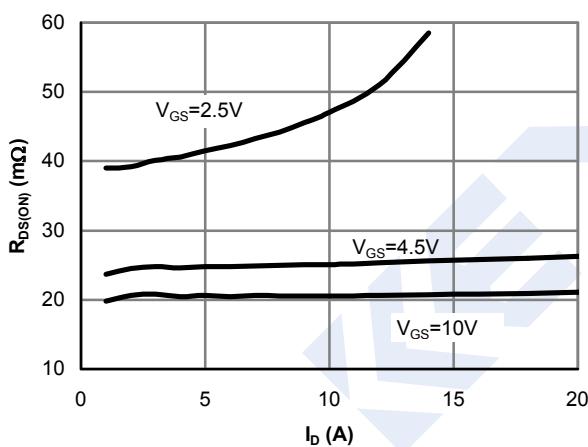


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

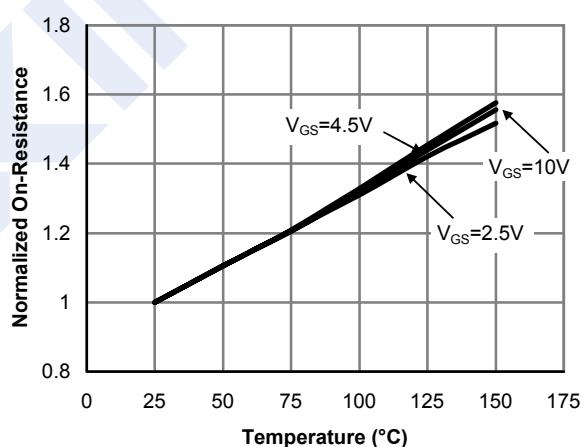


Figure 4: On-Resistance vs. Junction Temperature

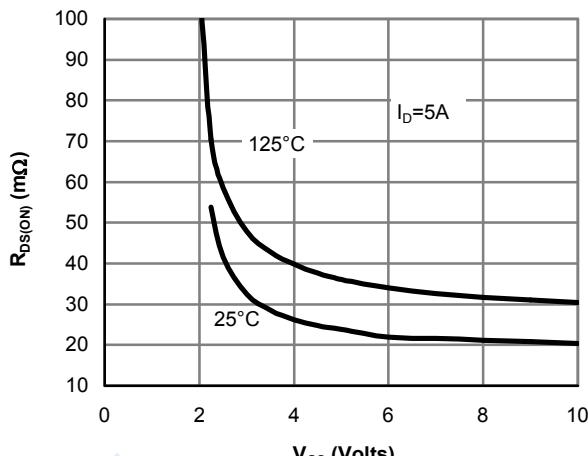


Figure 5: On-Resistance vs. Gate-Source Voltage

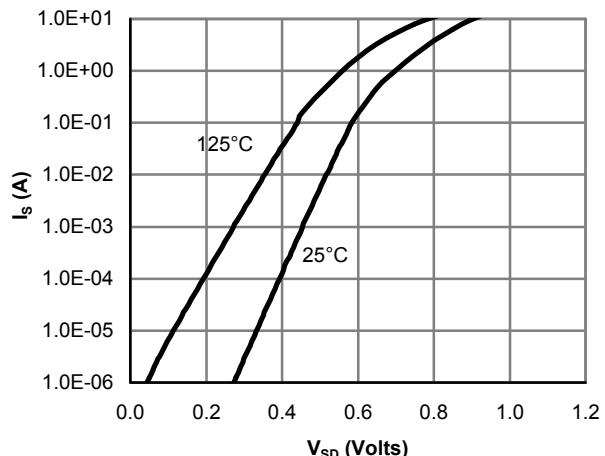


Figure 6: Body-Diode Characteristics

## N-Channel MOSFET

### AO4404 (KO4404)

#### ■ Typical Characteristics

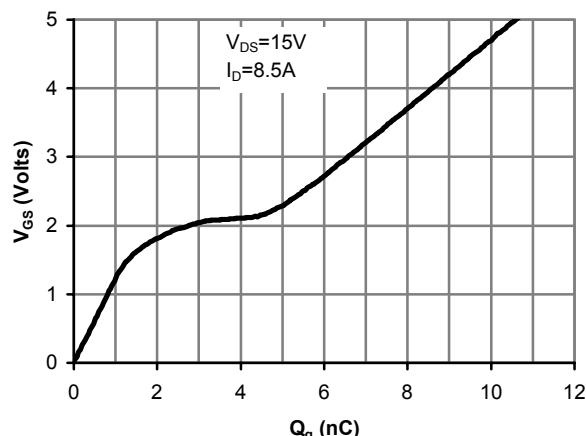


Figure 7: Gate-Charge Characteristics

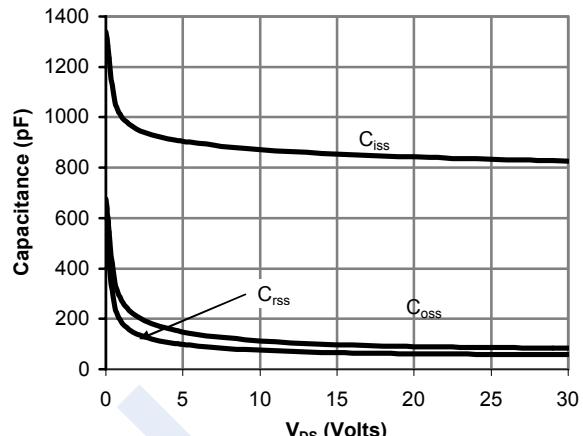


Figure 8: Capacitance Characteristics

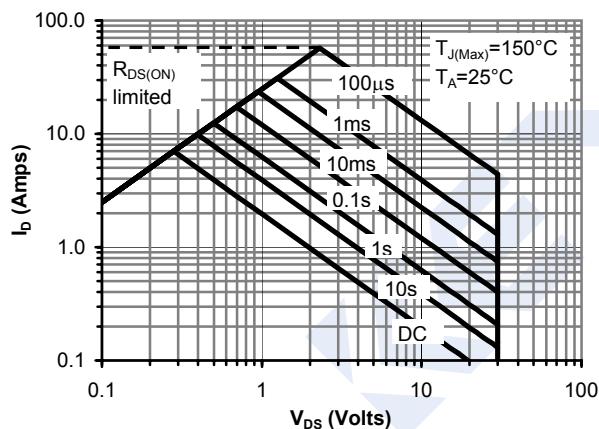


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

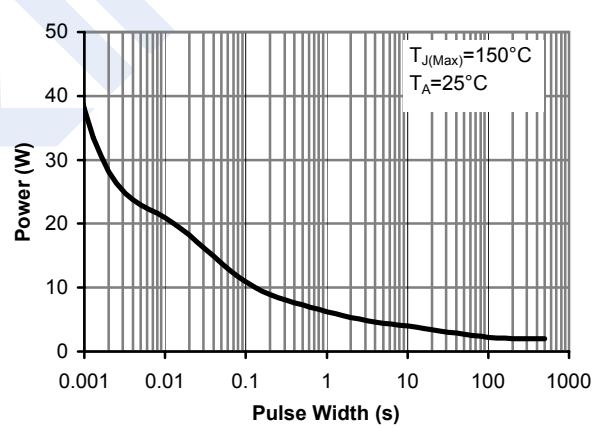


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

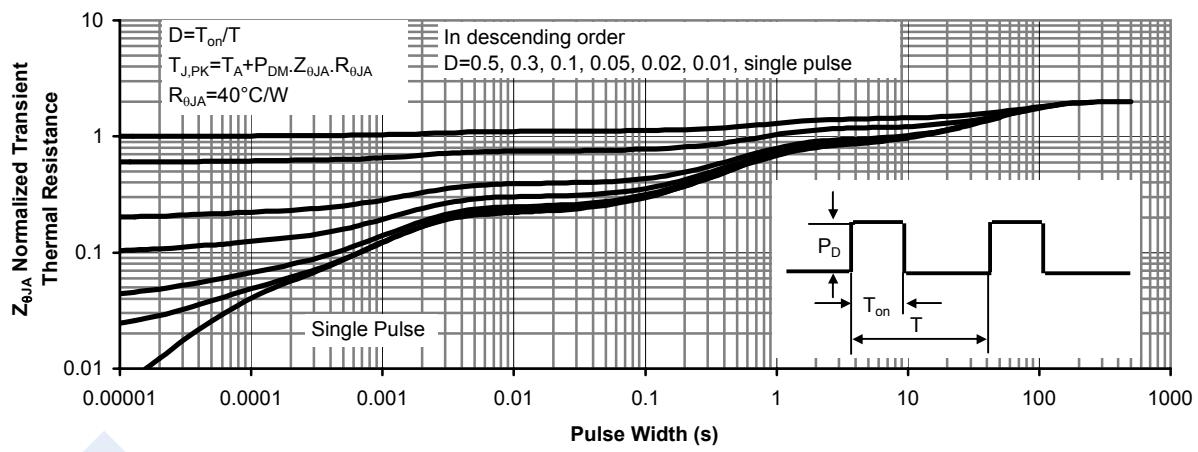


Figure 11: Normalized Maximum Transient Thermal Impedance